# 600 V / 4 A, High-Side Automotive Gate Driver IC

## **FAN7171-F085**

#### **Description**

The FAN7171-F085 is a monolithic high-side gate drive IC that can drive high-speed MOSFETs and IGBTs that operate up to +600 V. It has a buffered output stage with all NMOS transistors designed for high pulse current driving capability and minimum cross-conduction.

ON Semiconductor's high-voltage process and common-mode noise-canceling techniques provide stable operation of the high-side driver under high-dv/dt noise circumstances. An advanced level-shift circuit offers high-side gate driver operation up to  $V_S = -9.8~V$  (typical) for  $V_{BS} = 15~V$ .

The UVLO circuit prevents malfunction when  $V_{BS}$  is lower than the specified threshold voltage.

The high-current and low-output voltage-drop feature make this device suitable for sustaining switch drivers and energy-recovery switch drivers in automotive motor drive inverters, switching power supplies, and high-power DC-DC converter applications.

#### **Features**

- Floating Channel for Bootstrap Operation to +600 V
- 4 A Sourcing and 4 A Sinking Current Driving Capability
- Common-Mode dv/dt Noise-Cancelling Circuit
- 3.3 V and 5 V Input Logic Compatible
- Output In-phase with Input Signal
- Under- Voltage Lockout for VBS
- 25 V Shunt Regulator on VDD and VBS
- 8-SOIC Package, Case 751EB (JEDEC MS-012, 0.150 inch Narrow Body)
- Automotive Qualified to AEC Q100 for Ambient Operating Temperature from -40°C to 125°C

## **Applications**

- Common Rail Injection Systems
- DC-DC Converter
- Motor Drive (Electric Power Steering, Fans)

#### **Related Product Resources**

- FAN7171-F085 Product Folder
- AN-6076 Design and Application Guide of Bootstrap Circuit for High-Voltage Gate-Drive IC
- AN-8102 200 Recommendations to Avoid Short Pulse Width Issues in HVIC Gate Driver Applications
- AN-9052 Design Guide for Selection of Bootstrap Components
- AN-4171 FAN7085 High-Side Gate Driver- Internal Recharge Path Design Considerations



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SOIC8 CASE 751EB

#### ORDERING INFORMATION

Device	Package	Shipping†
FAN7171M-F085	Case 751EB	Tube
FAN7171MX-F085	(Pb-Free / Halogen Free)	Tape & Reel

- †For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure. BRD8011/D.
- 1. These devices passed wave soldering test by JESD22A-111.
- A suffix as "...F085P" has been temporarily introduced in order to manage a double source strategy as ON Semiconductor has officially announced in Aug 2014.

## **TYPICAL APPLICATION**

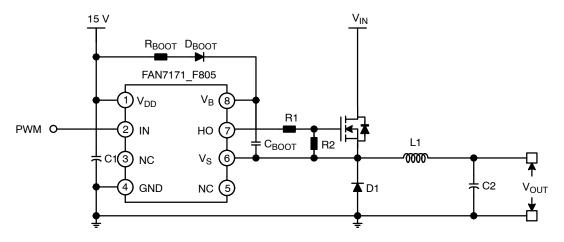


Figure 1. Typical Application

## **BLOCK DIAGRAM**

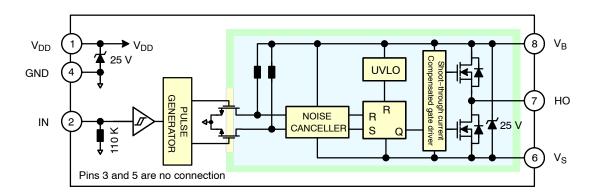


Figure 2. Block Diagram

## **PIN CONFIGURATION**

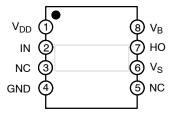


Figure 3. Pin Assignment (Top Through View)

**Table 1. PIN DESCRIPTIONS** 

Pin #	Name	Description
1	$V_{DD}$	Supply Voltage
2	IN	Logic Input for High-Side Gate Driver Output
3	NC	No Connection
4	GND	Ground
5	NC	No Connection
6	V <sub>S</sub>	High-Voltage Floating Supply Return
7	НО	High-Side Driver Output
8	V <sub>B</sub>	High-Side Floating Supply

**Table 2. ABSOLUTE MAXIMUM RATINGS** 

Symbol	Characteristics	Min.	Max.	Unit
V <sub>S</sub>	High-Side Floating Offset Voltage	V <sub>B</sub> -V <sub>SHUNT</sub>	V <sub>B</sub> +0.3	V
V <sub>B</sub>	High-Side Floating Supply Voltage (Note 3)	-0.3	625.0	V
V <sub>HO</sub>	High-Side Floating Output Voltage	V <sub>S</sub> -0.3	V <sub>B</sub> +0.3	V
$V_{DD}$	Low-Side and Logic Supply Voltage (Note 3)	-0.3	V <sub>SHUNT</sub>	V
V <sub>IN</sub>	Logic Input Voltage	-0.3	V <sub>DD</sub> +0.3	V
dV <sub>S</sub> /dt	Allowable Offset Voltage Slew Rate		±50	V/ns
P <sub>D</sub>	Power Dissipation (Notes 4, 5, 6)		0.625	W
$\theta_{\sf JA}$	Thermal Resistance		200	°C/W
T <sub>J</sub>	Junction Temperature	-55	150	°C
T <sub>STG</sub>	Storage Temperature	-55	150	°C
T <sub>A</sub>	Operating Ambient Temperature	-40	125	°C
FOD	Human Body Model (HBM)		2000	V
ESD	Charge Device Model (CDM)		500	\ \ \

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

 5. Refer to the following standards: JESD51-2: Integral circuits thermal test method environmental conditions, natural convection, and JESD51-3: Low effective thermal conductivity test board for leaded surface-mount packages.

**Table 3. RECOMMENDED OPERATING CONDITIONS** 

Symbol	Characteristics	Min.	Max.	Unit
V <sub>BS</sub>	High-Side Floating Supply Voltage	V <sub>S</sub> +10	V <sub>S</sub> +20	V
	High-Side Floating Supply Offset Voltage (DC)	6-V <sub>DD</sub>		
V <sub>S</sub>	High-Side Floating Supply Offset Voltage (Transient)	-15 (~170)	600	V
		-7 (~400)		
V <sub>HO</sub>	High-Side Output Voltage	Vs	V <sub>B</sub>	V
V <sub>IN</sub>	Logic Input Voltage	GND	$V_{DD}$	V
V <sub>DD</sub>	Supply Voltage	10	20	V
T <sub>PULSE</sub>	Minimum Input Pulse Width (Note 7)	80	-	ns

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

This IC contains a shunt regulator on V<sub>DD</sub> and V<sub>BS</sub> with a normal breakdown voltage of 25 V. Please note that this supply pin should not be driven by a low-impedance voltage source greater than the V<sub>SHUNT</sub> specified in the Electrical Characteristics section.

<sup>4.</sup> Mounted on 76.2 x 114.3 x 1.6 mm PCB (FR-4 glass epoxy material).

<sup>6.</sup> Do not exceed power dissipation (PD) under any circumstances.

7. Input pulses shorter than the minimum recommendation can cause abnormal output. Short input pulses can be turn on pulses (i.e., rising edge to the adjacent falling edge), turn off pulses (i.e., falling edge to the adjacent rising edge) but also parasitic pulses induced by noise. Refer to Figure 24 and Figure 25. Value guaranteed by design.

## **Table 4. ELECTRICAL CHARACTERISTICS**

 $(V_{BIAS}~(V_{DD},~V_{BS}) = 15~V,~-40^{\circ}C \le T_{A} \le 125^{\circ}C,~unless~otherwise~specified.$  The  $V_{IN}~and~I_{IN}~parameters~are~referenced~to~GND.$  The  $V_{O}~and~I_{O}~parameters~are~relative~to~V_{S}~and~are~applicable~to~the~respective~output~HO)$ 

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
POWER S	UPPLY SECTION			•	•	•
I <sub>QDD</sub>	Quiescent V <sub>DD</sub> Supply Current	V <sub>IN</sub> = 0 V or 5 V		25	70	μΑ
I <sub>PDD</sub>	Operating V <sub>DD</sub> Supply Current	f <sub>IN</sub> = 20 kHz, No Load		35	100	μΑ
BOOTSTR	APPED SUPPLY SECTION					
V <sub>BSUV+</sub>	V <sub>BS</sub> Supply Under-Voltage Positive-Going Threshold Voltage	V <sub>BS</sub> = Sweep	8.2	9.2	10.2	V
V <sub>BSUV</sub> -	V <sub>BS</sub> Supply Under-Voltage Negative-Going Threshold Voltage	V <sub>BS</sub> = Sweep	7.5	8.5	9.5	V
V <sub>BSHYS</sub>	V <sub>BS</sub> Supply UVLO Hysteresis Voltage	V <sub>BS</sub> = Sweep		0.6		V
I <sub>LK</sub>	Offset Supply Leakage Current	V <sub>B</sub> = V <sub>S</sub> = 600 V			50	μΑ
I <sub>QBS</sub>	Quiescent V <sub>BS</sub> Supply Current	V <sub>IN</sub> = 0 V or 5 V		60	120	μΑ
I <sub>PBS</sub>	Operating V <sub>BS</sub> Supply Current	C <sub>LOAD</sub> = 1 nF, f <sub>IN</sub> = 20 kHz, RMS Value		0.73	2.80	mA
SHUNT RE	GULATOR SECTION			•	•	•
V <sub>SHUNT</sub>	V <sub>DD</sub> and V <sub>BS</sub> Shunt Regulator Clamping Voltage	I <sub>SHUNT</sub> = 5 mA	23	25		V
NPUT LO	GIC SECTION (IN)					
V <sub>IH</sub>	Logic "1" Input Voltage		2.5			V
V <sub>IL</sub>	Logic "0" Input Voltage				0.8	V
I <sub>IN+</sub>	Logic Input High Bias Current	V <sub>IN</sub> = 5 V		45	125	μΑ
I <sub>IN-</sub>	Logic Input Low Bias Current	V <sub>IN</sub> = 0 V			2	μΑ
R <sub>IN</sub>	Input Pull-down Resistance		40	110		kΩ
GATE DRI	VER OUTPUT SECTION (HO)					
V <sub>OH</sub>	High Level Output Voltage (V <sub>BIAS</sub> – V <sub>O</sub> )	No Load			1.5	V
V <sub>OL</sub>	Low Level Output Voltage	No Load			35	mV
I <sub>O+</sub>	Output High, Short-Circuit Pulsed Current (Note 8)	$V_{HO} = 0 \text{ V},$ $V_{IN} = 5 \text{ V},$ $PW \le 10 \mu\text{s}$	3.0	4.0		А
I <sub>O</sub> _	Output Low, Short-Circuit Pulsed Current (Note 8)	$V_{HO}$ = 15 V, $V_{IN}$ = 0 V, $PW \le 10 \mu s$	3.0	4.0		А
Vs	Allowable Negative V <sub>S</sub> Pin Voltage for IN Signal Propagation to HO			-9.8	-7.0	٧

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

8. These parameters guaranteed by design.

#### **Table 5. DYNAMIC ELECTRICAL CHARACTERISTICS**

 $(V_{BIAS}~(V_{DD},~V_{BS}) = 15~V,~V_S = GND = 0~V,~C_L = 1000~pF,~and~-40^{\circ}C \le T_A \le 125^{\circ}C,~unless~otherwise~specified)$ 

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
t <sub>ON</sub>	Turn-On Propagation Delay	V <sub>S</sub> = 0 V		150	210	ns
t <sub>OFF</sub>	Turn-Off Propagation Delay	V <sub>S</sub> = 0 V		150	210	ns

## Table 5. DYNAMIC ELECTRICAL CHARACTERISTICS (continued)

 $(V_{BIAS}\;(V_{DD},\,V_{BS})=15\;V,\,V_S=GND=0\;V,\,C_L=1000\;pF,\,and\,-40^{\circ}C\leq T_A\leq 125^{\circ}C,\,unless\;otherwise\;specified)$ 

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
t <sub>R</sub>	Turn-On Rise Time			25	50	ns
t <sub>F</sub>	Turn-Off Fall Time			15	45	ns

## TYPICAL PERFORMANCE CHARACTERISTICS

250

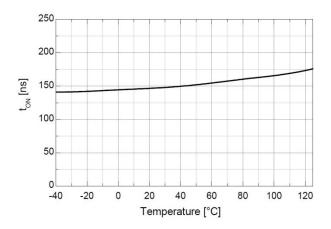


Figure 4. Turn-On Propagation Delay vs. Temperature

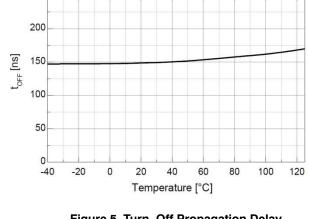


Figure 5. Turn-Off Propagation Delay vs. Temperature

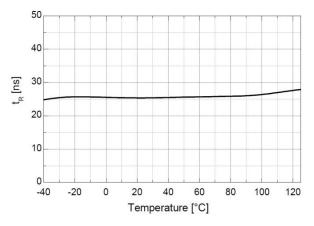


Figure 7. Turn-On Rise Time vs. Temperature

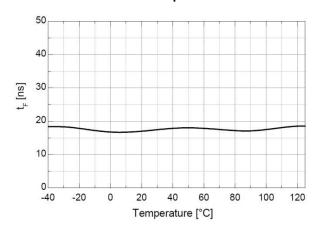


Figure 6. Turn-Off Fall Time vs.
Temperature

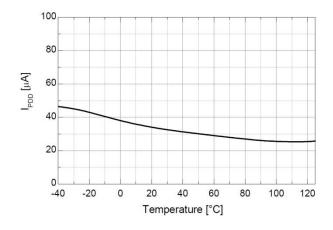


Figure 9. Operating V<sub>DD</sub> Supply Current vs. Temperature

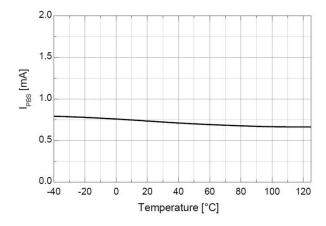
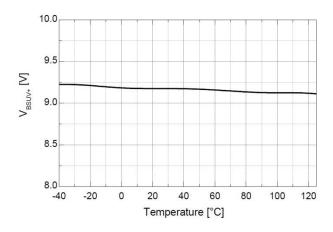


Figure 8. Operating V<sub>BS</sub> Supply Current vs. Temperature

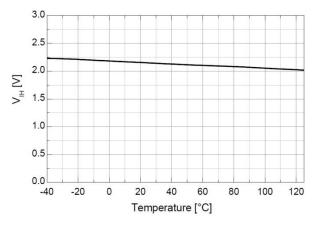
## TYPICAL PERFORMANCE CHARACTERISTICS (continued)



9.5 9.0 8.5 8.0 7.5 -40 -20 0 20 40 60 80 100 120 Temperature [°C]

Figure 10. V<sub>BS</sub> UVLO+ vs. Temperature

Figure 11. V<sub>BS</sub> UVLO- vs. Temperature



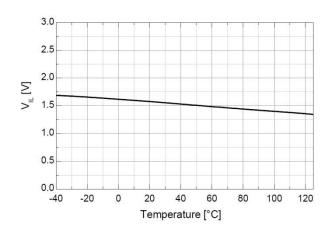
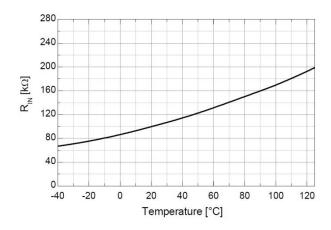


Figure 13. Logic High Input Voltage vs. Temperature

Figure 12. Logic Low Input Voltage vs. Temperature



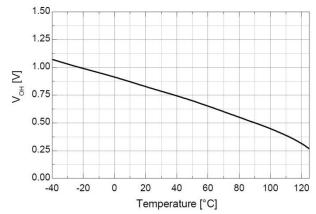


Figure 15. Input Pull-Down Resistance vs. Temperature

Figure 14. High-Level output Voltage vs. Temperature

## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

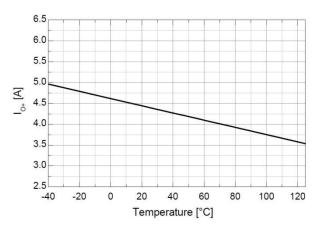


Figure 16. Output High, Short-Circuit Pulsed Current vs. Temperature

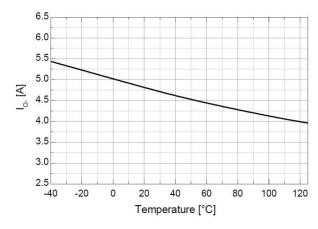


Figure 17. Output Low, Short-Circuit Pulsed Current vs. Temperature

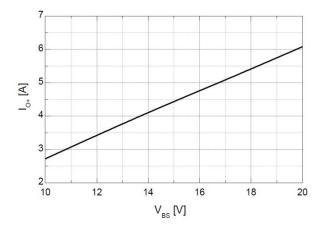


Figure 19. Output High, Short-Circuit Pulsed Current vs. Supply Voltage

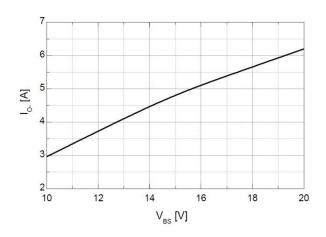


Figure 18. Output Low, Short-Circuit Pulsed Current vs. Supply Voltage

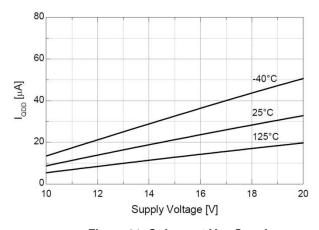


Figure 21. Quiescent V<sub>DD</sub> Supply Current vs. Supply Voltage

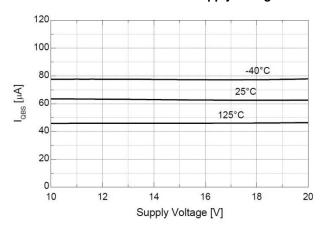


Figure 20. Quiescent V<sub>BS</sub> Supply Current vs. Supply Voltage

## **SWITCHING TIME DEFINITIONS**

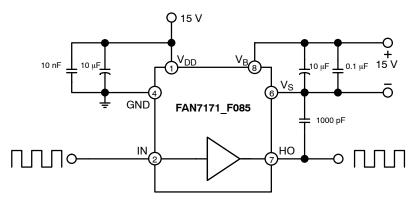


Figure 22. Switching Time Test Circuit ( Referenced 8-SOIC)

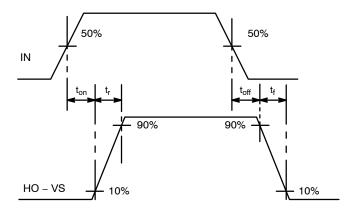


Figure 23. Switching Time Waveform Definitions

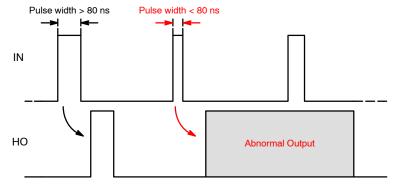


Figure 24. Output Waveform with Short Turn On Input Pulse Width

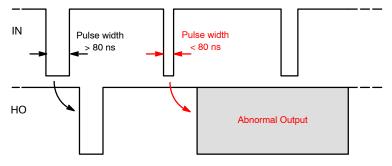
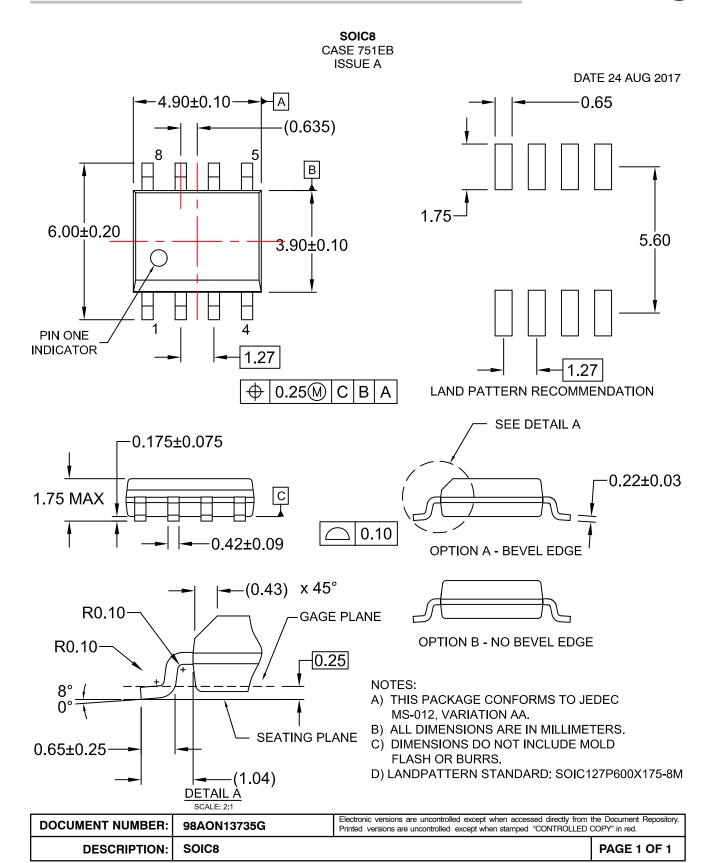


Figure 25. Output Waveform with Short Turn Off Input Pulse Width



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